

<b>Notice of References Cited</b>	Application/Control No. 10/076,609	Applicant(s)/Patent Under Reexamination KITAYAMA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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	N	EP 0955143 A2	11-1999	EPO	Kobayashi et al	
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**NON-PATENT DOCUMENTS**

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